

MOSFETs Silicon N-Channel MOS (DTMOSIV)

# TK6P60W

#### 1. Applications

· Switching Voltage Regulators

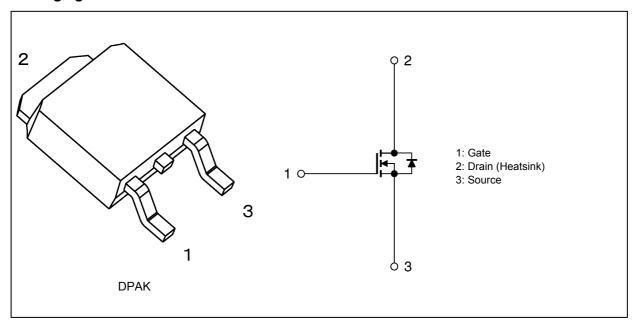
#### 2. Features

(1) Low drain-source on-resistance:  $R_{DS(ON)}$  = 0.68  $\Omega$  (typ.) by used to Super Junction Structure: DTMOS

(2) Easy to control Gate switching

(3) Enhancement mode:  $V_{th}$  = 2.7 to 3.7 V ( $V_{DS}$  = 10 V,  $I_{D}$  = 0.31 mA)

#### 3. Packaging and Internal Circuit



### 4. Absolute Maximum Ratings (Note) (Ta = 25°C unless otherwise specified)

| Characteristics                       | Symbol   | Rating           | Unit       |    |
|---------------------------------------|----------|------------------|------------|----|
| Drain-source voltage                  |          | V <sub>DSS</sub> | 600        | V  |
| Gate-source voltage                   |          | V <sub>GSS</sub> | ±30        |    |
| Drain current (DC)                    | (Note 1) | I <sub>D</sub>   | 6.2        | Α  |
| Drain current (pulsed)                | (Note 1) | I <sub>DP</sub>  | 24.8       |    |
| Power dissipation (T <sub>c</sub> = 2 | 25°C)    | P <sub>D</sub>   | 60         | W  |
| Single-pulse avalanche energy         | (Note 2) | E <sub>AS</sub>  | 84         | mJ |
| Avalanche current                     |          | I <sub>AR</sub>  | 1.6        | Α  |
| Reverse drain current (DC)            | (Note 1) | I <sub>DR</sub>  | 6.2        |    |
| Reverse drain current (pulsed)        | (Note 1) | I <sub>DRP</sub> | 24.8       |    |
| Channel temperature                   |          | T <sub>ch</sub>  | 150        | °C |
| Storage temperature                   |          | T <sub>stg</sub> | -55 to 150 |    |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



#### 5. Thermal Characteristics

| Characteristics                    | Symbol                | Max  | Unit |
|------------------------------------|-----------------------|------|------|
| Channel-to-case thermal resistance | R <sub>th(ch-c)</sub> | 2.09 | °C/W |

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 57.6 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = 1.6 A

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.



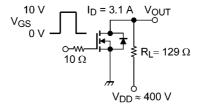
#### 6. Electrical Characteristics

### 6.1. Static Characteristics (T<sub>a</sub> = 25°C unless otherwise specified)

| Characteristics                | Symbol               | Test Condition                                    | Min | Тур. | Max  | Unit |
|--------------------------------|----------------------|---|-----|------|------|------|
| Gate leakage current           | I <sub>GSS</sub>     | $V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$ | _   |      | ±1   | μА   |
| Drain cut-off current          | I <sub>DSS</sub>     | V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V    | _   | _    | 10   |      |
| Drain-source breakdown voltage | V <sub>(BR)DSS</sub> | I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V     | 600 | _    | _    | V    |
| Gate threshold voltage         | $V_{th}$             | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 0.31 mA  | 2.7 | _    | 3.7  |      |
| Drain-source on-resistance     | R <sub>DS(ON)</sub>  | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.1 A    | _   | 0.68 | 0.82 | Ω    |

### 6.2. Dynamic Characteristics (T<sub>a</sub> = 25°C unless otherwise specified)

| Characteristics                | Symbol             | Test Condition  | Min | Тур. | Max | Unit |
|--------------------------------|--------------------|---|-----|------|-----|------|
| Input capacitance              | C <sub>iss</sub>   | V <sub>DS</sub> = 300 V, V <sub>GS</sub> = 0 V, f = 1 MHz | _   | 390  |     | pF   |
| Reverse transfer capacitance   | C <sub>rss</sub>   |   | _   | 1.7  |     |      |
| Output capacitance             | C <sub>oss</sub>   |   | _   | 12   |     |      |
| Effective output capacitance   | C <sub>o(er)</sub> | V <sub>DS</sub> = 0 to 400 V, V <sub>GS</sub> = 0 V       | _   | 20   | _   |      |
| Gate resistance                | r <sub>g</sub>     | V <sub>DS</sub> = OPEN, f = 1 MHz                         | _   | 7.5  | _   | Ω    |
| Switching time (rise time)     | t <sub>r</sub>     | See Figure 6.2.1  | _   | 18   | _   | ns   |
| Switching time (turn-on time)  | t <sub>on</sub>    |   | _   | 40   | _   |      |
| Switching time (fall time)     | t <sub>f</sub>     |   | _   | 7    | _   |      |
| Switching time (turn-off time) | t <sub>off</sub>   |   | _   | 55   | _   |      |
| MOSFET dv/dt ruggedness        | dv/dt              | V <sub>DD</sub> = 0 to 400 V, I <sub>D</sub> = 3.1 A      | 25  | _    | _   | V/ns |



 $Duty \leq 1\%, \ t_W = 10 \ \mu s$ 

Fig. 6.2.1 Switching Time Test Circuit

### 6.3. Gate Charge Characteristics (T<sub>a</sub> = 25°C unless otherwise specified)

| Characteristics                                 | Symbol           | Test Condition   | Min | Тур. | Max | Unit |
|---|------------------|--|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | Qg               | $V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 6.2 \text{ A}$ | _   | 12   |     | nC   |
| Gate-source charge 1                            | Q <sub>gs1</sub> |  |     | 3    |     |      |
| Gate-drain charge                               | $Q_{gd}$         |  |     | 6    |     |      |

### 6.4. Source-Drain Characteristics (T<sub>a</sub> = 25°C unless otherwise specified)

| Characteristics               | Symbol          | Test Condition   | Min | Тур. | Max  | Unit |
|-------------------------------|-----------------|--|-----|------|------|------|
| Diode forward voltage         | $V_{DSF}$       | I <sub>DR</sub> = 6.2 A, V <sub>GS</sub> = 0 V                         | 1   | _    | -1.7 | V    |
| Reverse recovery time         | t <sub>rr</sub> | $I_{DR}$ = 3.1 A, $V_{GS}$ = 0 V<br>- $dI_{DR}/dt$ = 100 A/ $\mu$ s    |     | 220  | _    | ns   |
| Reverse recovery charge       | $Q_{rr}$        |  |     | 1.6  | _    | μС   |
| Peak reverse recovery current | I <sub>rr</sub> |  | _   | 15   | _    | Α    |
| Diode dv/dt ruggedness        | dv/dt           | $I_{DR} = 3.1 \text{ A}, V_{GS} = 0 \text{ V}, V_{DD} = 400 \text{ V}$ | 15  | _    | _    | V/ns |

TK6P60W



## 7. Marking

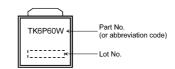


Fig. 7.1 Marking

#### 8. Characteristics Curves (Note)

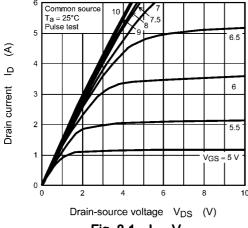
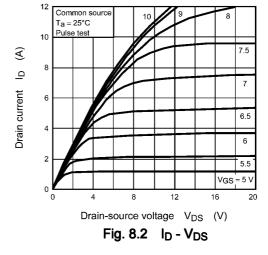


Fig. 8.1 I<sub>D</sub> - V<sub>DS</sub>



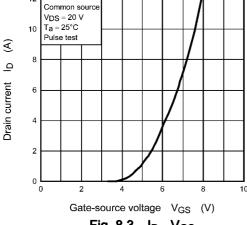


Fig. 8.3 I<sub>D</sub> - V<sub>GS</sub>

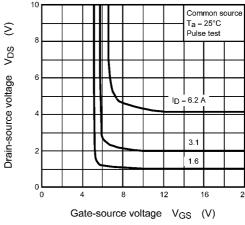


Fig. 8.4 V<sub>DS</sub> - V<sub>GS</sub>

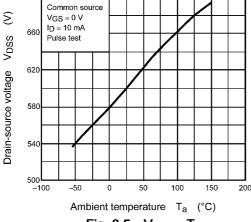


Fig. 8.5 V<sub>DSS</sub> - T<sub>a</sub>

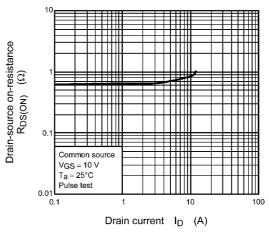


Fig. 8.6 R<sub>DS(ON)</sub> - I<sub>D</sub>

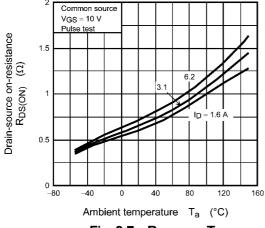


Fig. 8.7 R<sub>DS(ON)</sub> - T<sub>a</sub>

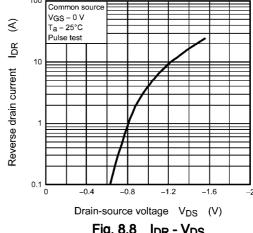


Fig. 8.8 IDR - VDS

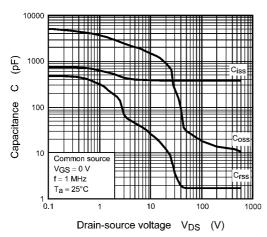


Fig. 8.9 C - V<sub>DS</sub>

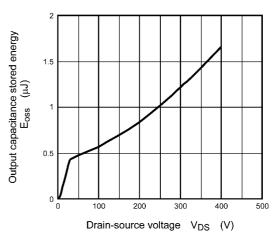


Fig. 8.10 Eoss - V<sub>DS</sub>

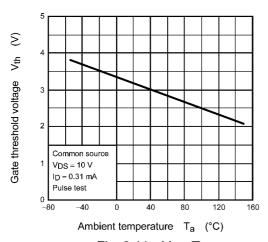


Fig. 8.11 V<sub>th</sub> - T<sub>a</sub>

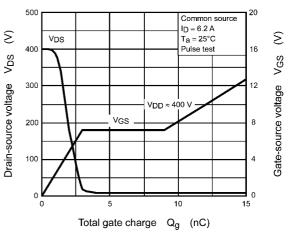


Fig. 8.12 Dynamic Input/Output Characteristics

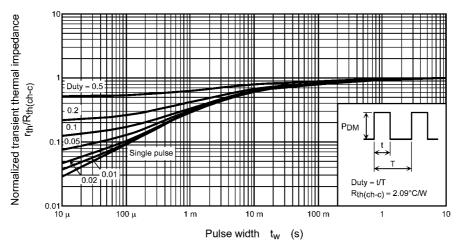


Fig. 8.13 r<sub>th</sub> - t<sub>w</sub> (Guaranteed Maximum)

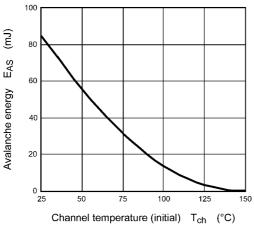


Fig. 8.14 E<sub>AS</sub> - T<sub>ch</sub> (Guaranteed Maximum)

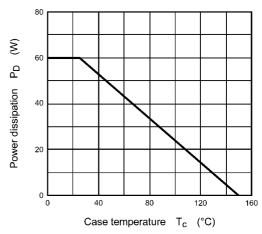


Fig. 8.15 P<sub>D</sub> - T<sub>c</sub> (Guaranteed Maximum)

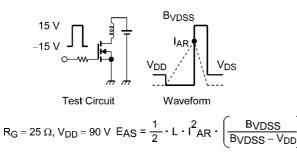


Fig. 8.16 Test Circuit/Waveform

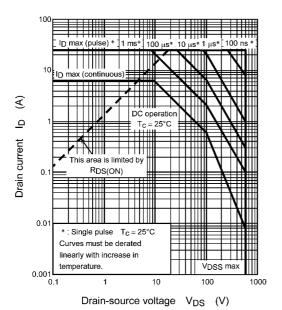


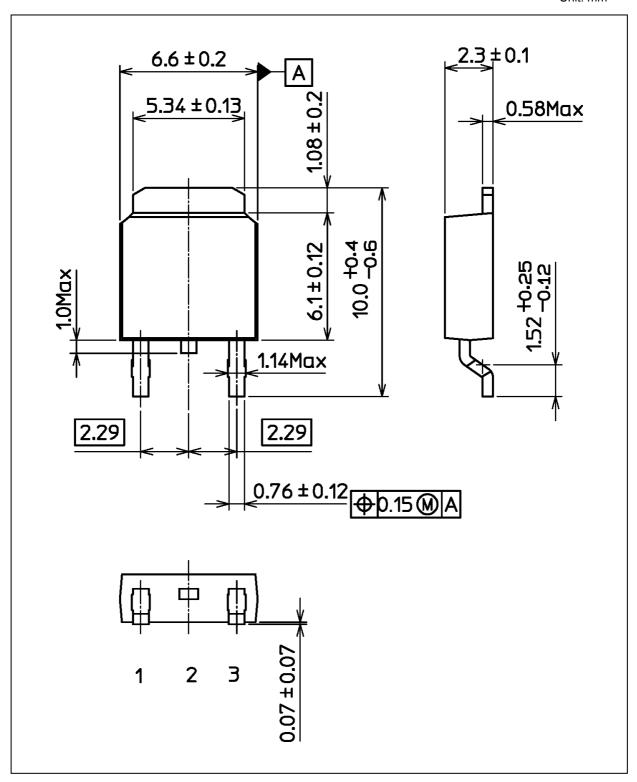
Fig. 8.17 Safe Operating Area (Guaranteed Maximum)

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



### **Package Dimensions**

Unit: mm



Weight: 0.36 g (typ.)

| Package Name(s) |  |
|-----------------|--|
| TOSHIBA: 2-7K1S |  |
| Nickname: DPAK  |  |



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